

Installation, calibration, and experimental verification of a layered deposition scheme

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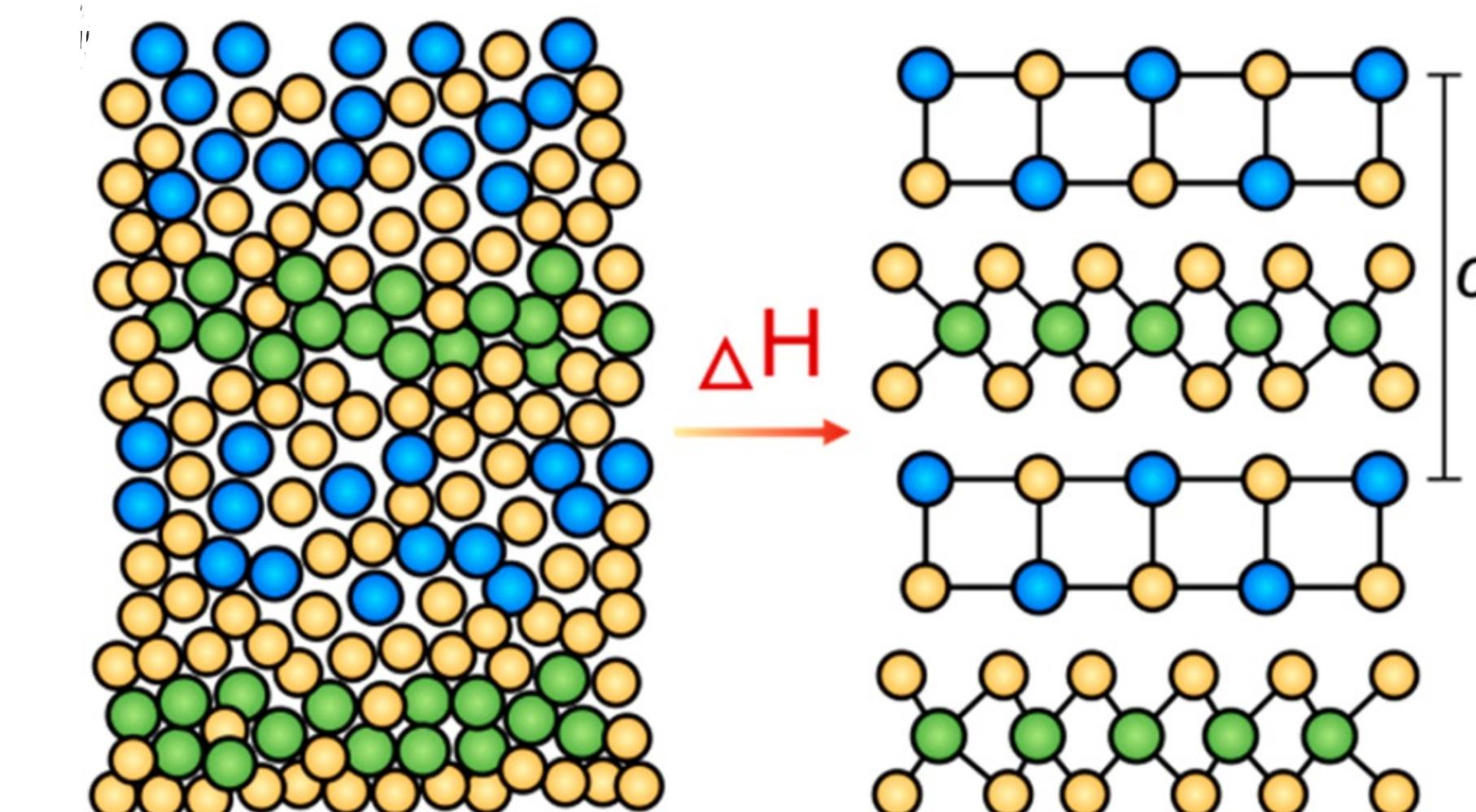
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Middlebury
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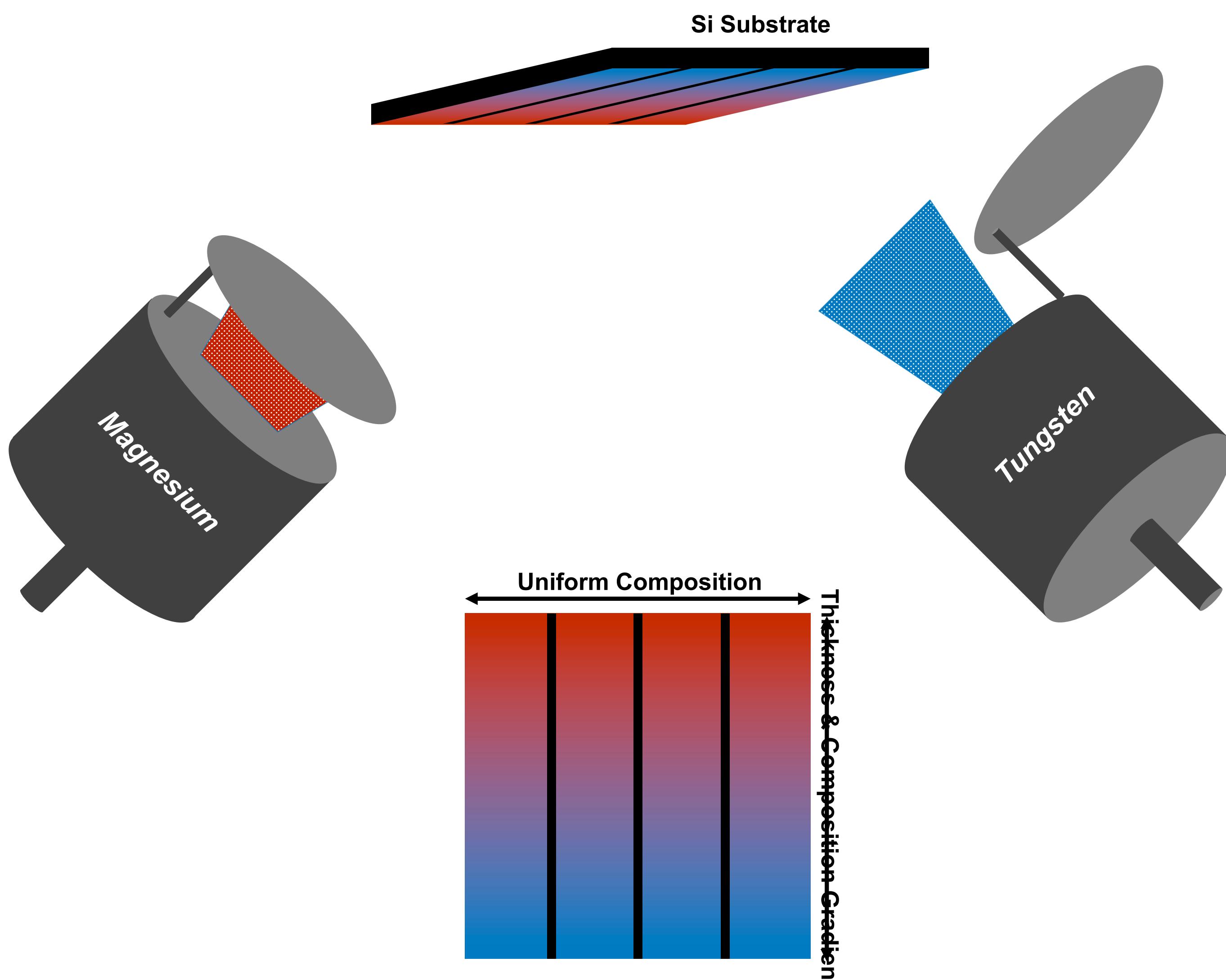
Introduction and Motivation

- Layered material deposition allows for the synthesis of previously undiscovered materials
- Depositing materials in amorphous layers at ambient temperature has been shown to facilitate reordering under annealing conditions
 - Prior research in chalcogenides (SnS and TaS₂) at NREL^{1,2}
 - Our goal is to expand this research to new materials, particularly nitrides³
- Exploring the viability of using high-vacuum magnetron sputtering to produce other novel nanoscale layered materials

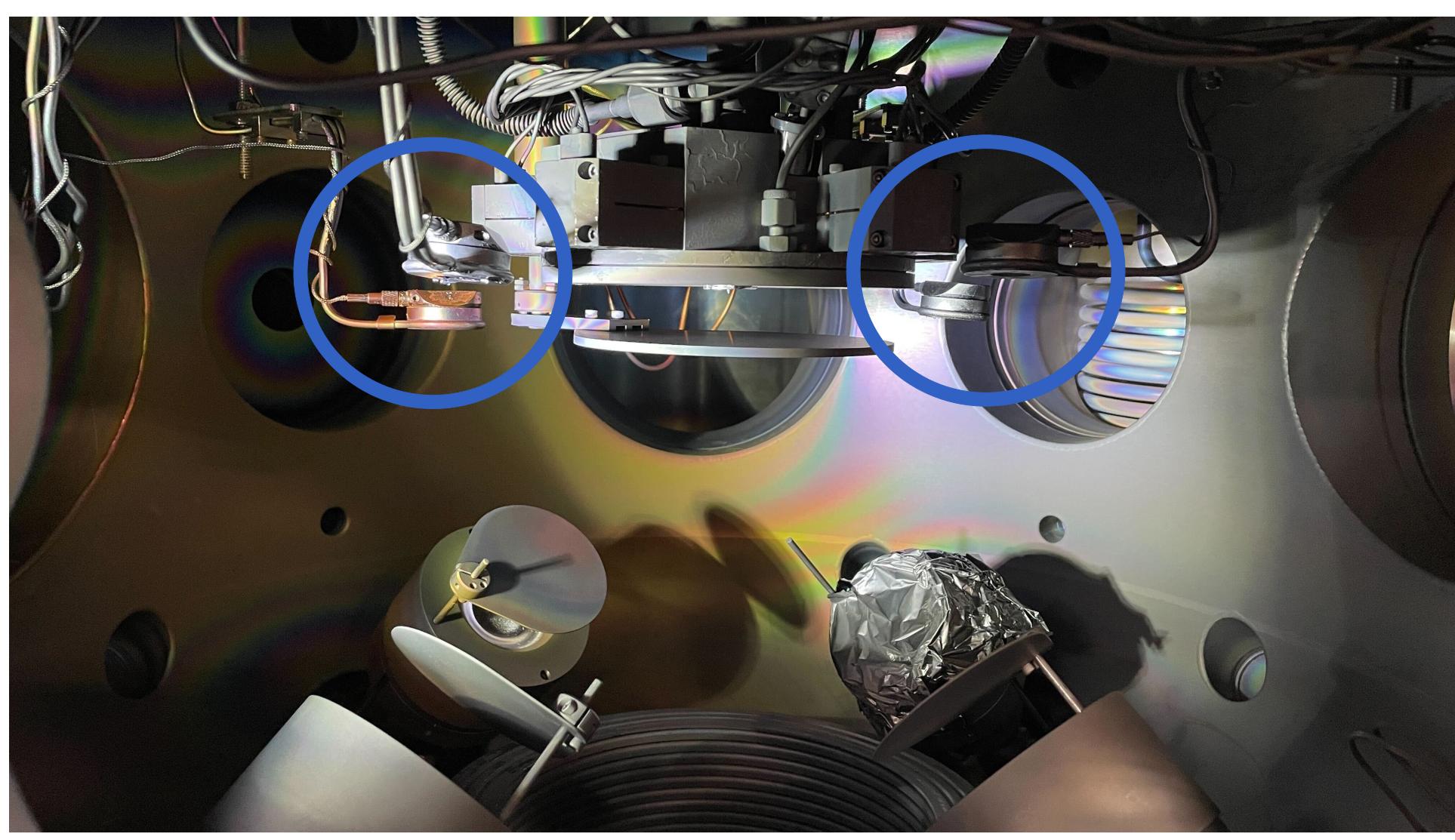
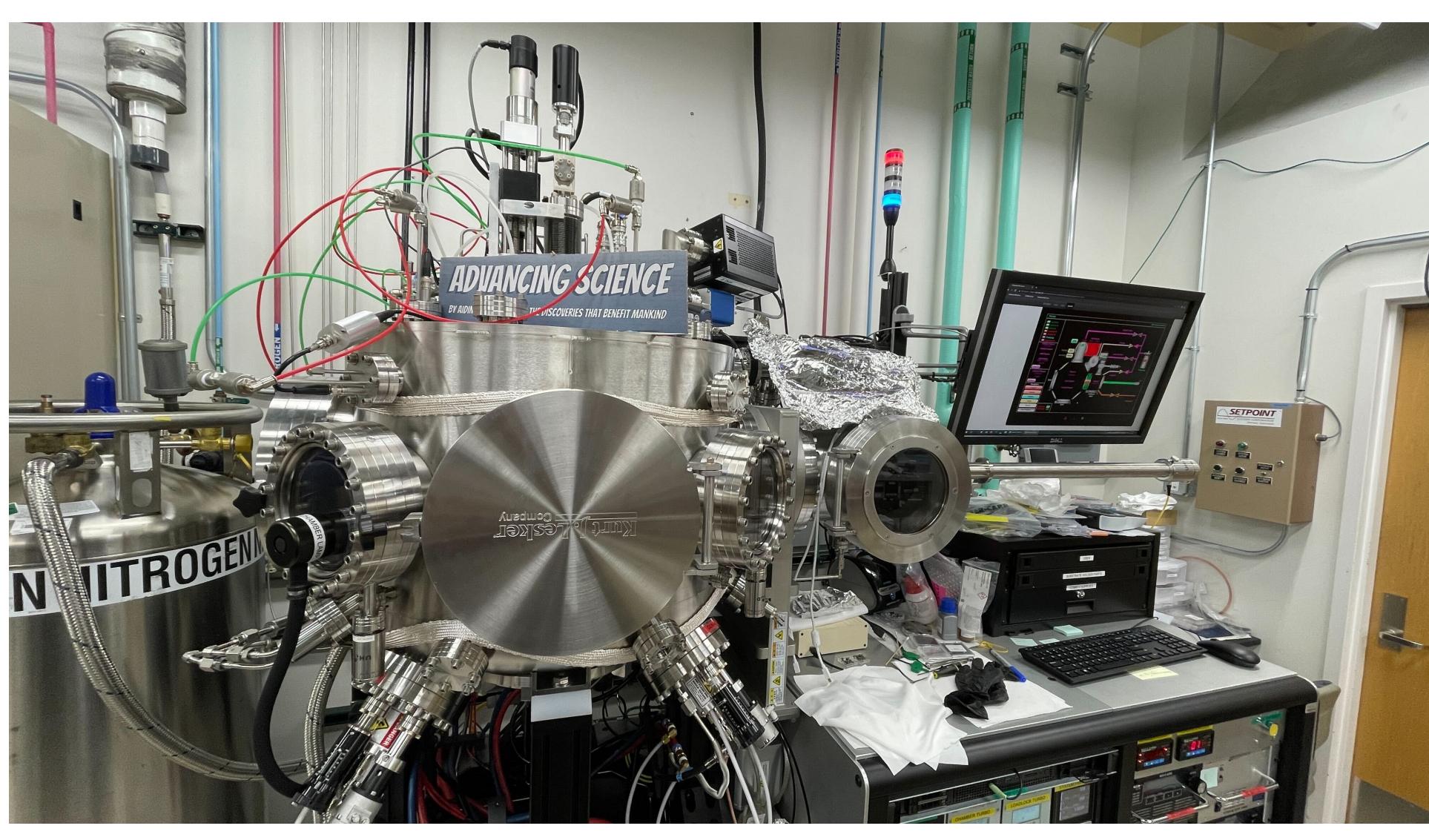


Amorphous material deposition reordering into a layered pattern under anneal.
Figure from Ref. 2

Sputtering Chamber Overview



Representation of sputter deposition setup with compositional gradient and substrate masking shown



Exterior and interior of Combi 9 sputtering chamber. Note QCMs circled in blue

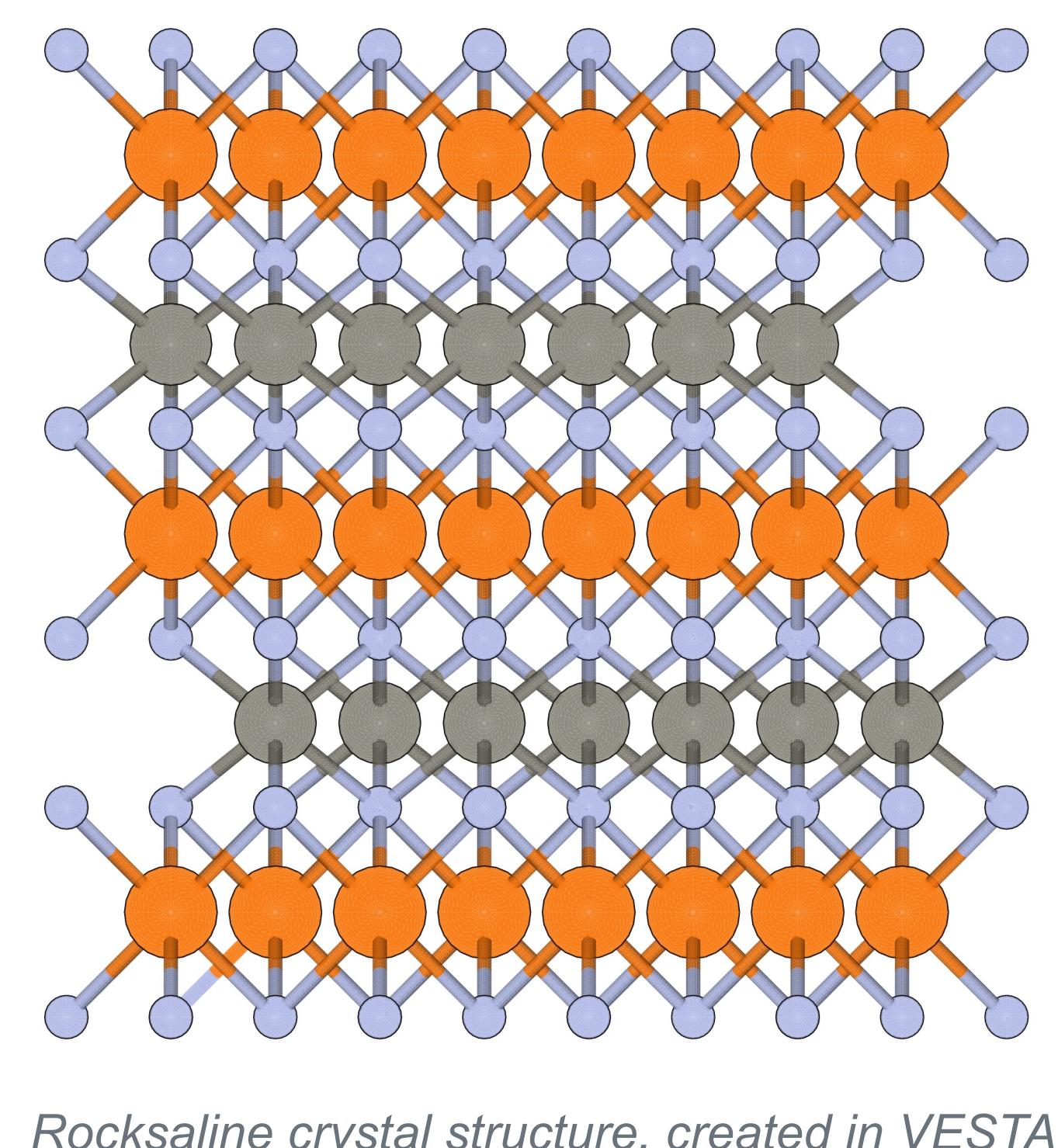
Sensor Installation

- Quartz crystal monitors (QCMs) installed above each sputtering gun, adjacent to substrate
- Water cooling lines run in parallel to each sensor to allow for high-temperature growths without compromising sensor integrity

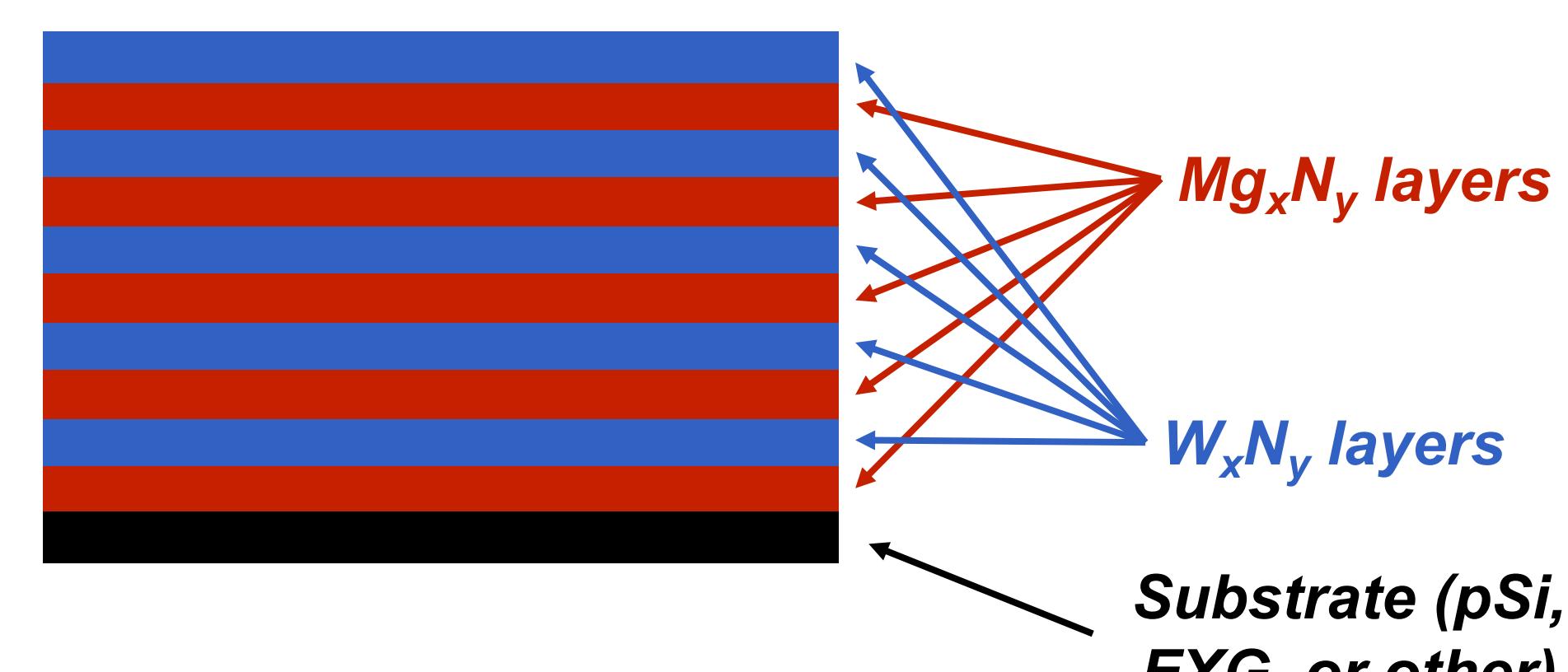
Sensor Calibration

- Several films of Mg_xN_y and W_xN_y produced under identical growth conditions
- Thickness determined by using Dektak8 profilometer and averaging across all films
- Film density, z-ratio, and tooling factor adjusted to ensure agreement between QCM thickness and measured thickness

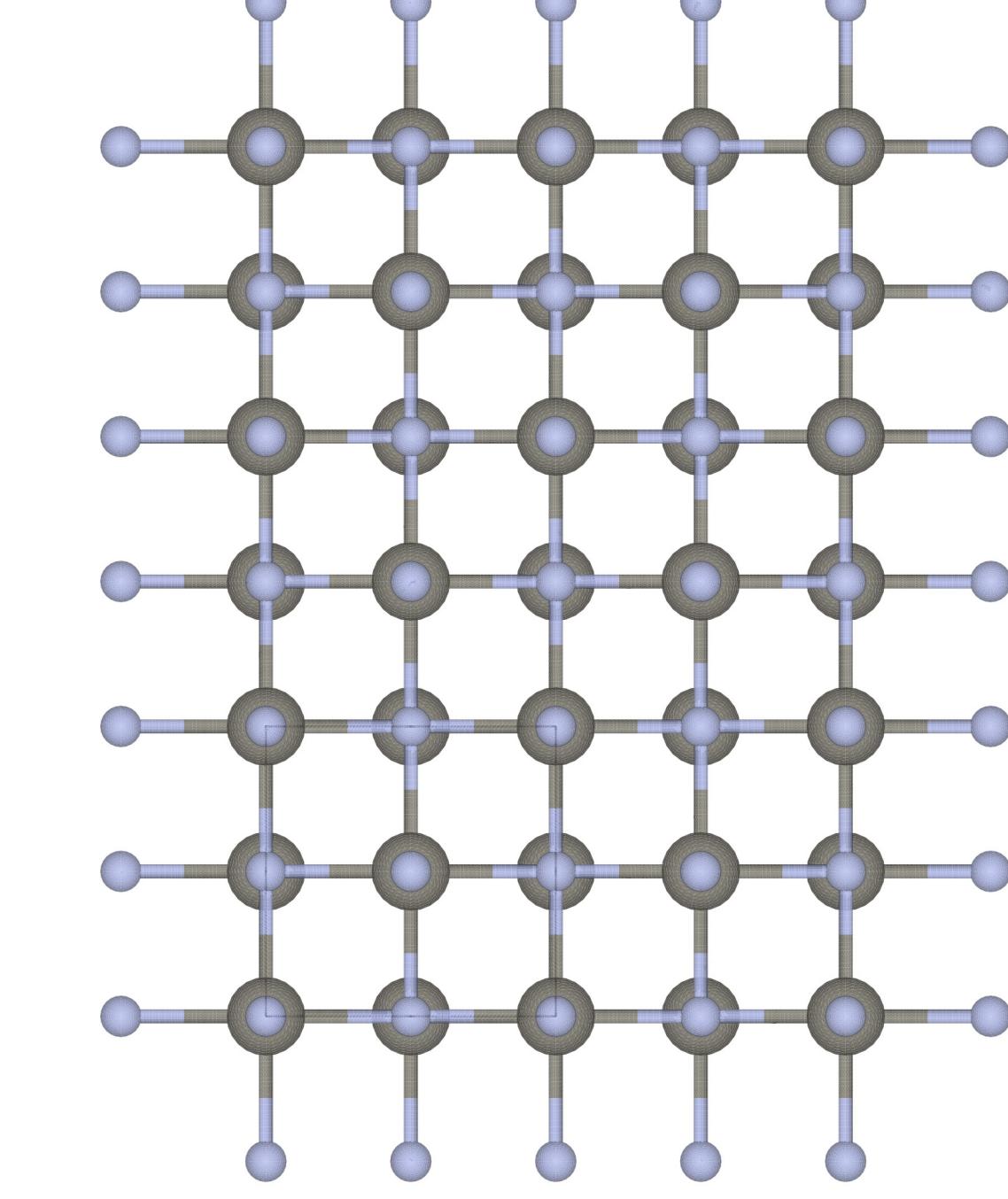
Testing Layered Growths with MgWN₂



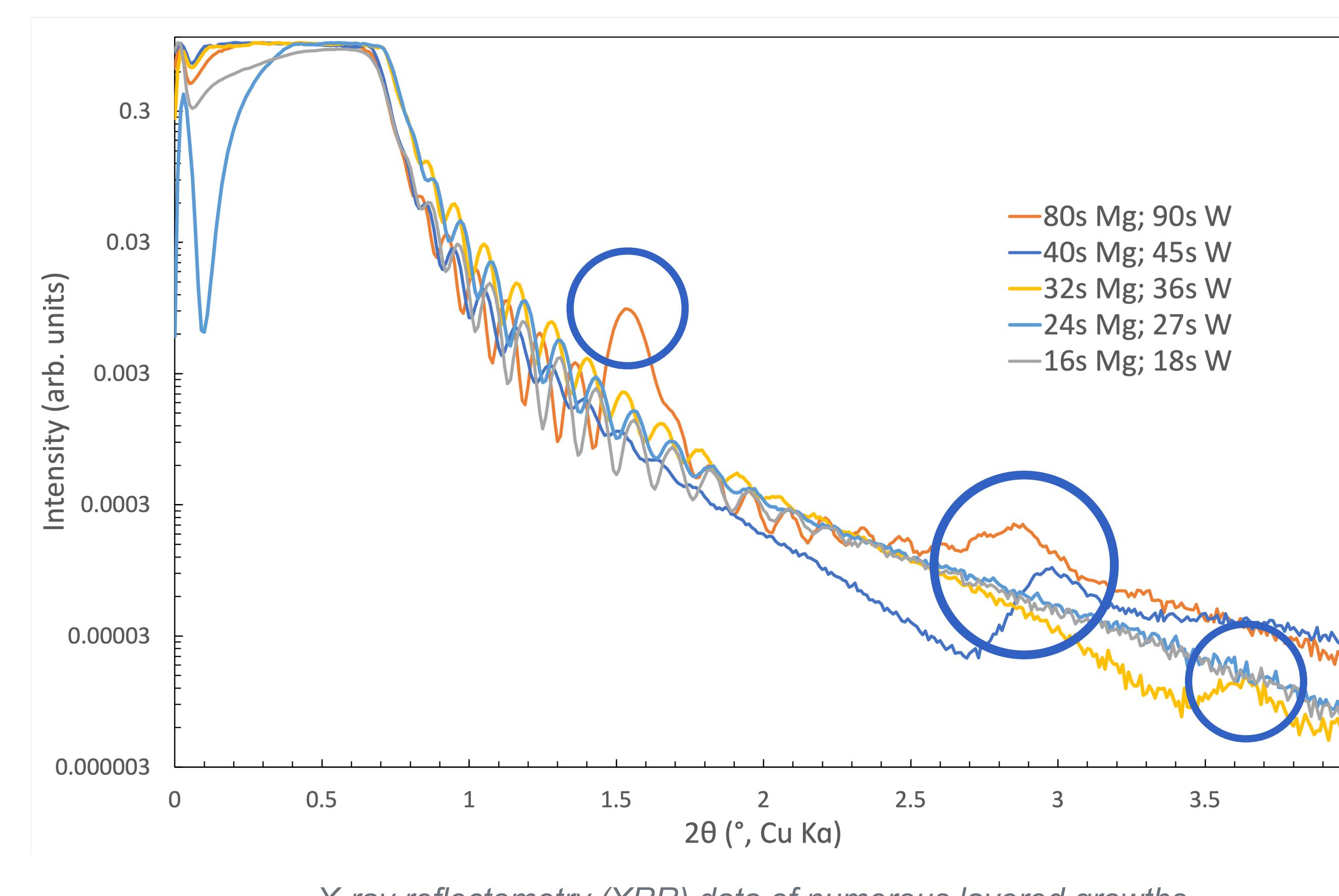
Rocksalt crystal structure, created in VESTA modeling software⁴



Idealized deposition composition of layered films, with distinct layers of Mg_xN_y and W_xN_y



Rocksalt crystal structure, created in VESTA modeling software⁴



X-ray reflectometry (XRR) data of numerous layered growths

Conclusions

- XRR data revealed that layering was present, though not at the desired layer thicknesses
- Future research will explore varying deposition conditions to increase likelihood of successful superstructure formation of MgWN₂ and other novel nitrides
 - Substrate temperature (employing a liquid N₂ substrate cooling system)
 - Gun power
 - Chamber pressure

Acknowledgements

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References

¹D. Roberts, et al., *J. Vac. Sci. Technol. B* **37**, 051201 (2019)

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